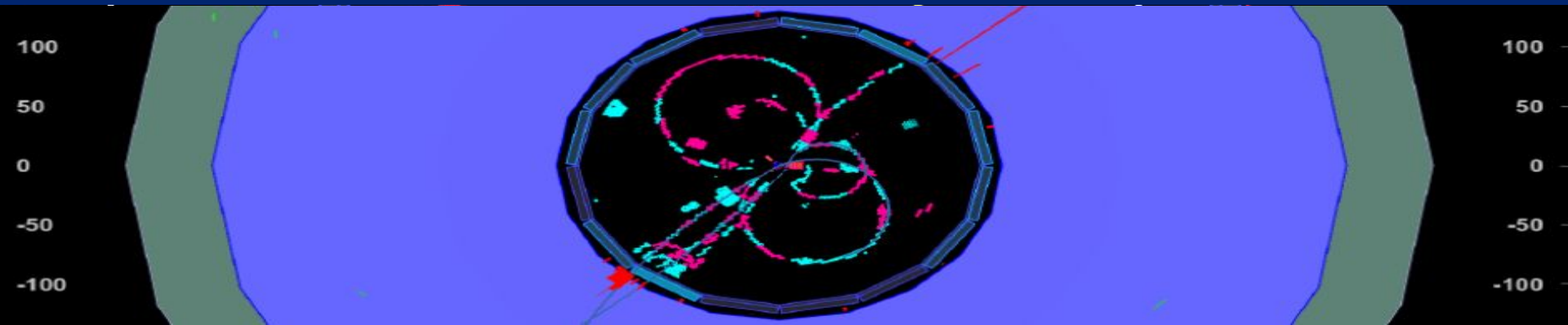


Status of χ_d measurement with SL double tagged events

[b2n-2019-014@belle2.org, [Note](#)]



BBAM

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Bundesministerium
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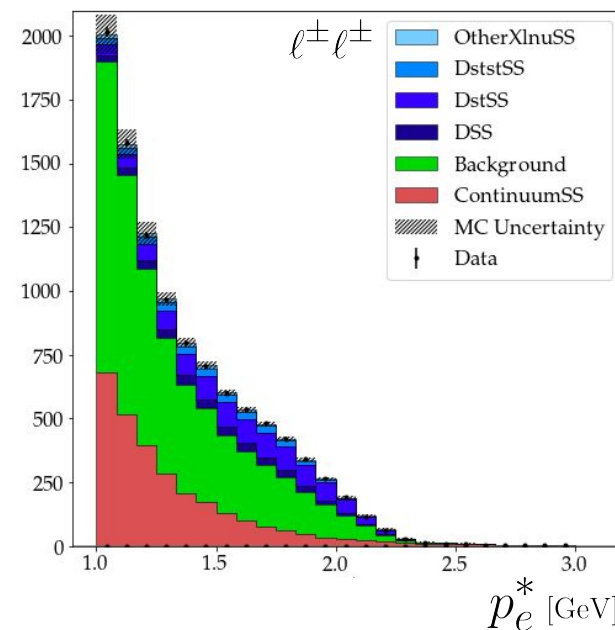
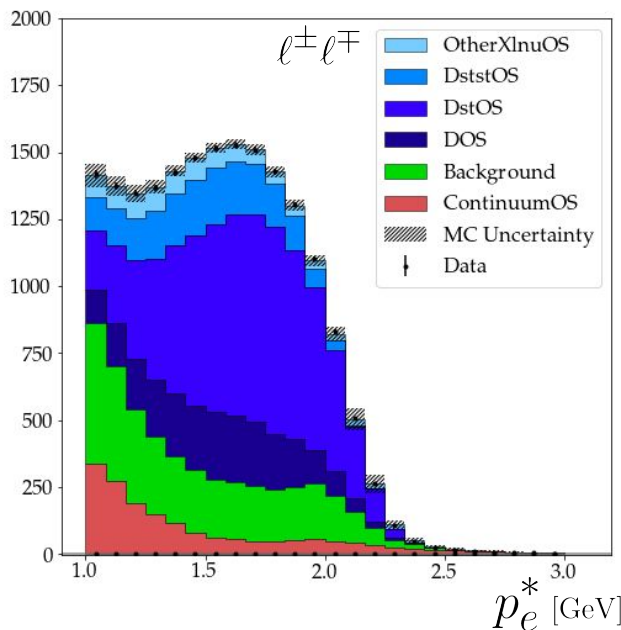
Asimov Fit to determine exp. sensitivity

<u>OS spectrum</u>	MC expectation	Fit result
Signal yield	12525.6 ± 33.2	12525.6 ± 504.2
Background yield	4338.6 ± 24.6	4338.6 ± 775.9
Continuum yield	1199.2 ± 15.6	1199.2 ± 376.1

$$\chi_{\text{MC}} = 0.0850 \pm 0.0006$$

$$\chi_{\text{fit}} = 0.0850 \pm 0.0184$$

<u>SS spectrum</u>	MC expectation	Fit result
Signal yield	1599.2 ± 11.8	1599.2 ± 374.6
Background yield	6302.4 ± 30.1	6302.4 ± 1053.1
Continuum yield	1957.2 ± 20.3	1957.2 ± 755.9



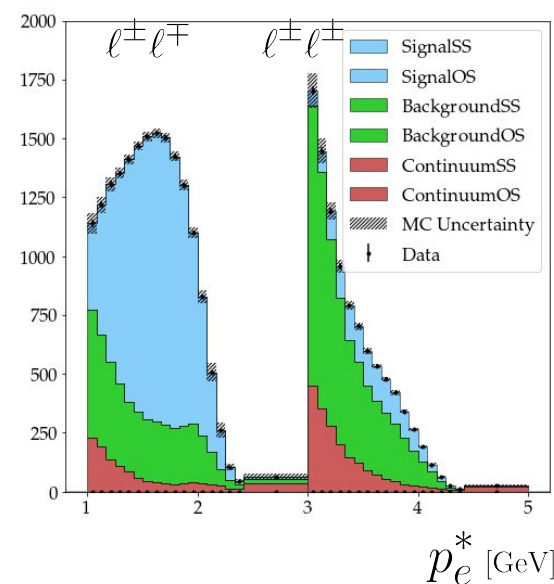
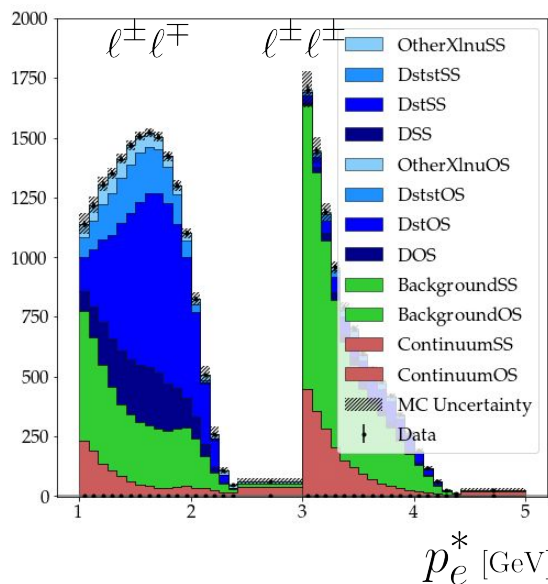
Asimov Fit to determine exp. sensitivity

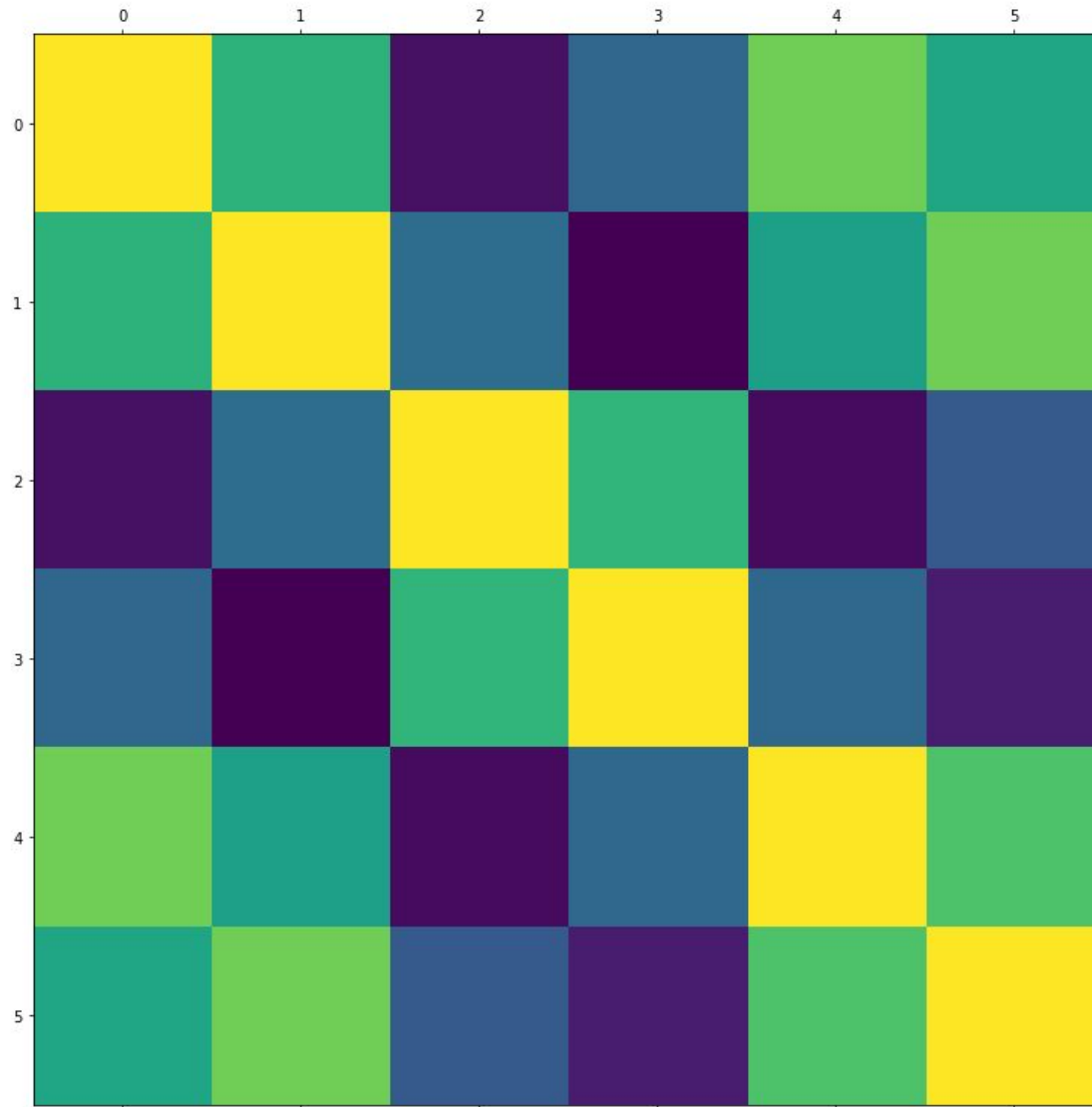
<u>OS spectrum</u>	Ind. fit result	Simul. Fit result
Signal yield	12525.6 ∓ 504.2	12525.6 ∓ 491.9
Background yield	4338.6 ∓ 775.9	4338.6 ∓ 763.8
Continuum yield	1199.2 ∓ 376.1	1199.2 ∓ 372.5

<u>SS spectrum</u>	Ind. expectation	Simul. Fit result
Signal yield	1599.2 ∓ 374.6	1599.2 ∓ 310.2
Background yield	6302.4 ∓ 1053.1	6302.4 ∓ 831.3
Continuum yield	1957.2 ∓ 755.9	1957.2 ∓ 610.6

$$\chi_{\text{fit}} = 0.0850 \pm 0.0184$$

$$\chi_{\text{simul. fit}} = 0.0850 \pm 0.0154$$





Backup